

Search Notes

Application No.

10/692,225

Examiner

Jean M Corrielus

Applicant(s)

VENKATESH ET AL.

Art Unit

2162

SEARCHED

| Class | Subclass | Date | Examiner |
|-------|----------|-----------|----------|
| 707 | 6 | 3/18/2005 | JMC |
| 707 | 7 | 3/18/2005 | JMC |
| 707 | 103 | 3/18/2005 | JMC |
| 707 | 102 | 3/18/2005 | JMC |
| 707 | 2 | 3/18/2005 | JMC |
| 715 | 866 | 3/18/2005 | JMC |
| 717 | 104 | 3/18/2005 | JMC |
| 717 | 122 | 3/18/2005 | JMC |
| 707 | 101 | 3/18/2005 | JMC |
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INTERFERENCE SEARCHED

| Class | Subclass | Date | Examiner |
|-------|----------|-----------|----------|
| 707 | 103 | 3/18/2005 | JMC |
| 707 | 6 | 3/18/2005 | JMC |
| 707 | 102 | 3/18/2005 | JMC |
| 707 | | 3/18/2005 | JMC |

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

| | DATE | EXMR |
|----------------|-----------|------|
| WEST | 3/18/2005 | JMC |
| NPL(IEEE, ACM) | 3/18/2005 | JMC |
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